

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/825,816	KIM ET AL.	
Examiner		Art Unit		Page 1 of 1
Chuc D. Tran		2821		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,678,289	01-2004	Kim, Jong-Ryeol	372/20
*	B	US-6,771,681	08-2004	Bang et al.	372/46.01
*	C	US-6,751,013	06-2004	Wu, Yongan	359/337
*	D	US-6,563,631	05-2003	Delprat et al.	359/344
*	E	US-6,865,020	03-2005	Kim et al.	359/344
*	F	US-6,980,345	12-2005	Kim et al.	359/248
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.